

Notice of References Cited	Application/Control No. 10/087,790	Applicant(s)/Patent Under Reexamination TANAKA ET AL.	
	Examiner Lisa Lea-Edmonds	Art Unit 2835	Page 1 of 1

U.S. PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
	A	US-4,510,215	04-1985	Adam, Michel	429/99
	B	US-D421,244	02-2000	Goto, Teiyu	D13/103
	C	US-D476,949	07-2003	Wada, Jo	D13/103
	D	US-D448,003	09-2001	Ogasawara, Shinichi	D13/103
	E	US-D415,466	10-1999	Kawa, Mitsuo	D13/103
	F	US-5,901,035	05-1999	Foster et al.	361/683
	G	US-6,078,496	06-2000	Oguchi et al.	361/683
	H	US-			
	I	US-			
	J	US-			
	K	US-			
	L	US-			
	M	US-			

FOREIGN PATENT DOCUMENTS

*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Country	Name	Classification
	N					
	O					
	P					
	Q					
	R					
	S					
	T					

NON-PATENT DOCUMENTS

*		include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	
	V	
	W	
	X	

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